

## N-Channel Enhancement Mode Field Effect Transistor

### Product Summary

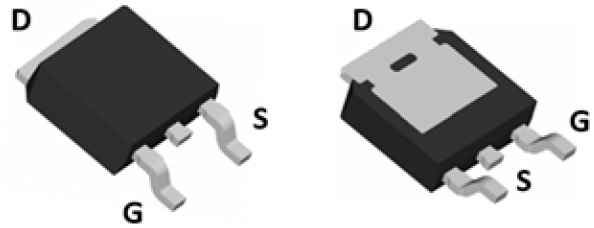
- $V_{DS}$  100V
- $I_D$  50A
- $R_{DS(ON)}$ ( at  $V_{GS}=10V$ ) < 17 mohm
- $R_{DS(ON)}$ ( at  $V_{GS}=4.5V$ ) < 21.5 mohm
- 100% UIS Tested
- 100%  $\nabla V_{DS}$  Tested

### General Description

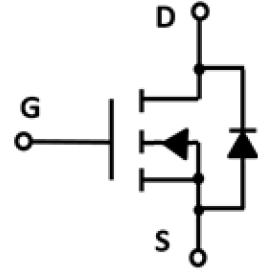
- Low  $R_{DS(on)}$  & FOM
- Extremely low switching loss
- Excellent stability and uniformity
- Fast switching and soft recovery

### Applications

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



TO-252



### ■ Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ unless otherwise noted)

| Parameter                              | Symbol         | Limit                   | Unit             |
|--|----------------|-------------------------|------------------|
| Drain-source Voltage                   | $V_{DS}$       | 100                     | V                |
| Gate-source Voltage                    | $V_{GS}$       | $\pm 20$                | V                |
| Drain Current                          | $I_D$          | $T_C=25^\circ\text{C}$  | 50               |
|  |                | $T_C=100^\circ\text{C}$ | 28.5             |
| Pulsed Drain Current <sup>A</sup>      | $I_{DM}$       | 180                     | A                |
| Avalanche energy <sup>B</sup>          | EAS            | 81                      | mJ               |
| Total Power Dissipation <sup>C</sup>   | $P_D$          | $T_C=25^\circ\text{C}$  | 72               |
|  |                | $T_C=100^\circ\text{C}$ | 28.8             |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55~+150                | $^\circ\text{C}$ |

### ■ Thermal resistance

| Parameter   | Symbol          | Typ          | Max | Units              |
|---|-----------------|--------------|-----|--------------------|
| Thermal Resistance Junction-to-Ambient <sup>D</sup> | $R_{\theta JA}$ | 15           | 20  | $^\circ\text{C/W}$ |
| Thermal Resistance Junction-to-Ambient <sup>D</sup> |                 | Steady-State | 40  |                    |
| Thermal Resistance Junction-to-Case                 | $R_{\theta JC}$ | 1.35         | 1.7 |                    |

**■ Electrical Characteristics (T<sub>j</sub>=25°C unless otherwise noted)**

| Parameter                             | Symbol              | Conditions  | Min | Typ  | Max  | Units |
|---------------------------------------|---------------------|---|-----|------|------|-------|
| <b>Static Parameter</b>               |                     |   |     |      |      |       |
| Drain-Source Breakdown Voltage        | BV <sub>DSS</sub>   | V <sub>GS</sub> = 0V, I <sub>D</sub> =250μA   | 100 |      |      | V     |
| Zero Gate Voltage Drain Current       | I <sub>DSS</sub>    | V <sub>DS</sub> =100V, V <sub>GS</sub> =0V  |     |      | 1    | μA    |
| Gate-Body Leakage Current             | I <sub>GSS</sub>    | V <sub>GS</sub> = ±20V, V <sub>DS</sub> =0V   |     |      | ±100 | nA    |
| Gate Threshold Voltage                | V <sub>GS(th)</sub> | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA                                 | 1   | 1.8  | 3    | V     |
| Static Drain-Source On-Resistance     | R <sub>DS(on)</sub> | V <sub>GS</sub> = 10V, I <sub>D</sub> =20A  |     | 14   | 17   | mΩ    |
|                                       |                     | V <sub>GS</sub> = 4.5V, I <sub>D</sub> =20A   |     | 17   | 21.5 | mΩ    |
| Diode Forward Voltage                 | V <sub>SD</sub>     | I <sub>S</sub> =20A, V <sub>GS</sub> =0V  |     |      | 1.3  | V     |
| Maximum Body-Diode Continuous Current | I <sub>S</sub>      |   |     |      | 45   | A     |
| Gate resistance                       | R <sub>G</sub>      | f= 1 MHz, Open drain  |     | 1    |      | Ω     |
| <b>Dynamic Parameters</b>             |                     |   |     |      |      |       |
| Input Capacitance                     | C <sub>iss</sub>    | V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, f=1MHZ   |     | 1135 |      | pF    |
| Output Capacitance                    | C <sub>oss</sub>    |   |     | 399  |      |       |
| Reverse Transfer Capacitance          | C <sub>rss</sub>    |   |     | 18   |      |       |
| <b>Switching Parameters</b>           |                     |   |     |      |      |       |
| Total Gate Charge                     | Q <sub>g</sub>      | V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =25A                           |     | 16   |      | nC    |
| Gate-Source Charge                    | Q <sub>gs</sub>     |   |     | 5.6  |      |       |
| Gate-Drain Charge                     | Q <sub>gd</sub>     |   |     | 2.4  |      |       |
| Reverse Recovery Chrage               | Q <sub>rr</sub>     | I <sub>F</sub> =20A, di/dt=100A/us  |     | 42   |      |       |
| Reverse Recovery Time                 | t <sub>rr</sub>     |   |     | 39.8 |      |       |
| Turn-on Delay Time                    | t <sub>D(on)</sub>  | V <sub>GS</sub> =10V, V <sub>DD</sub> =50V, I <sub>D</sub> =25A<br>R <sub>GEN</sub> =2.2Ω |     | 39.2 |      | ns    |
| Turn-on Rise Time                     | t <sub>r</sub>      |   |     | 11   |      |       |
| Turn-off Delay Time                   | t <sub>D(off)</sub> |   |     | 53.2 |      |       |
| Turn-off fall Time                    | t <sub>f</sub>      |   |     | 15.8 |      |       |

A. Repetitive rating; pulse width limited by max. junction temperature.

B. V<sub>DD</sub>=50V, V<sub>GS</sub>=10V, L=5mH, I<sub>AS</sub>=5.7A.

C. Pd is based on max. junction temperature, using junction-case thermal resistance.

D. The value of RqJA is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C. The Power dissipation PDSM is based on R qJA ≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

■ Typical Performance Characteristics

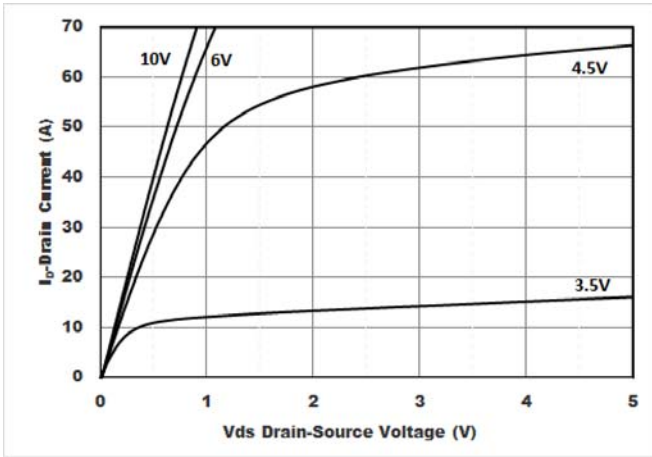


Figure1. Output Characteristics

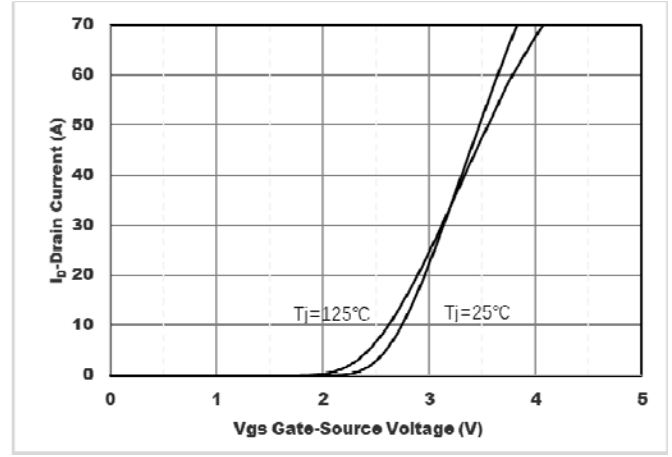


Figure2. Transfer Characteristics

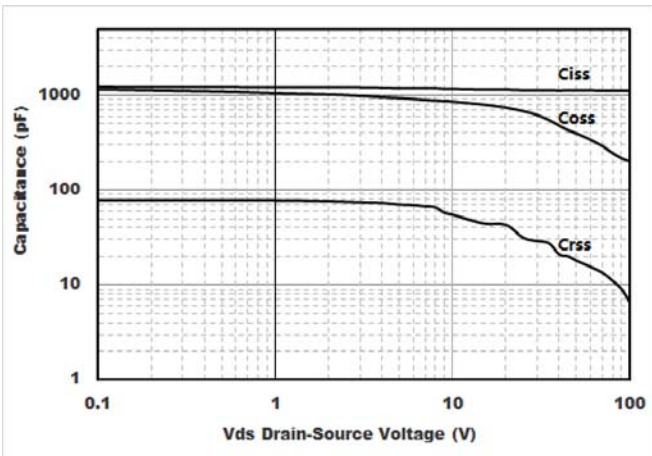


Figure3. Capacitance Characteristics

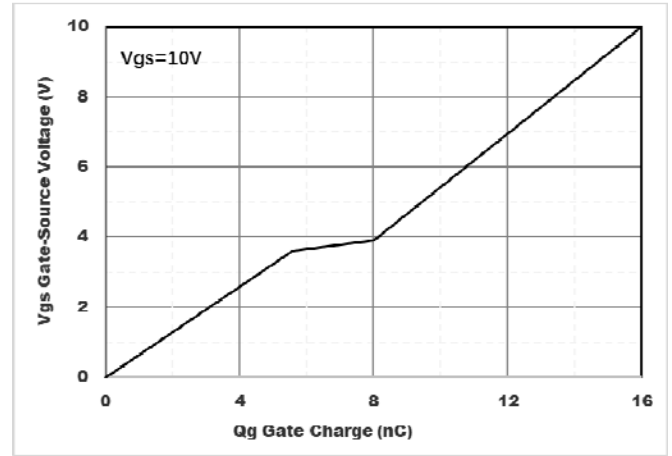


Figure4. Gate Charge

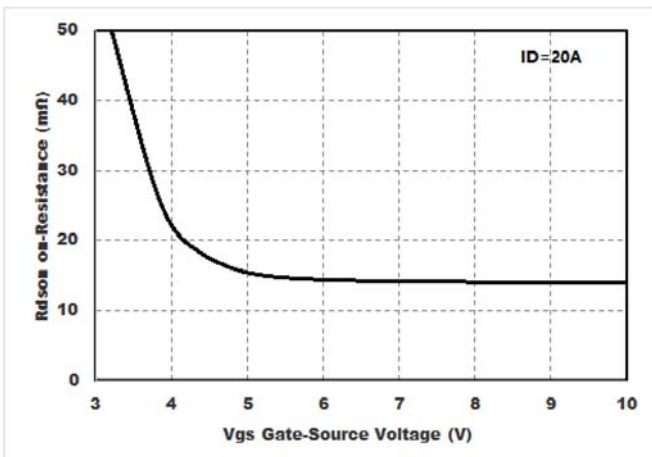


Figure5. : On-Resistance vs. Drain Current and Gate Voltage

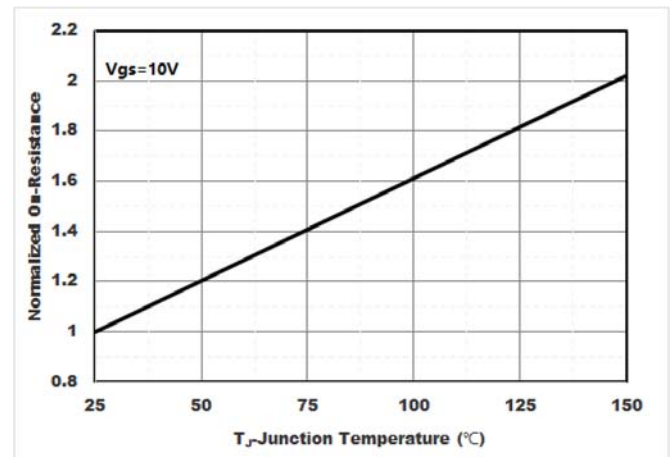


Figure6. Normalized On-Resistance

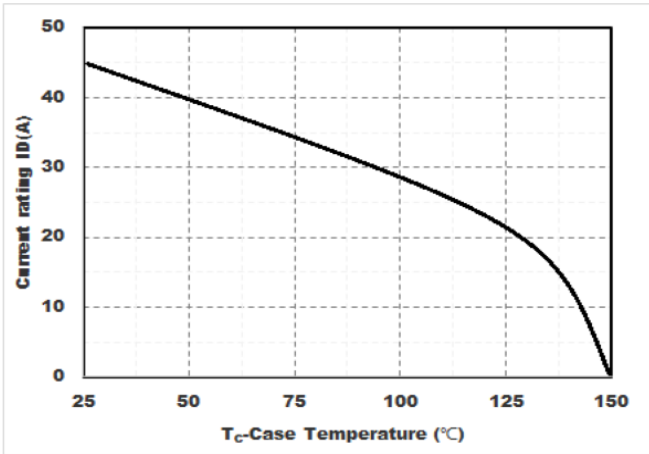


Figure7. Drain current

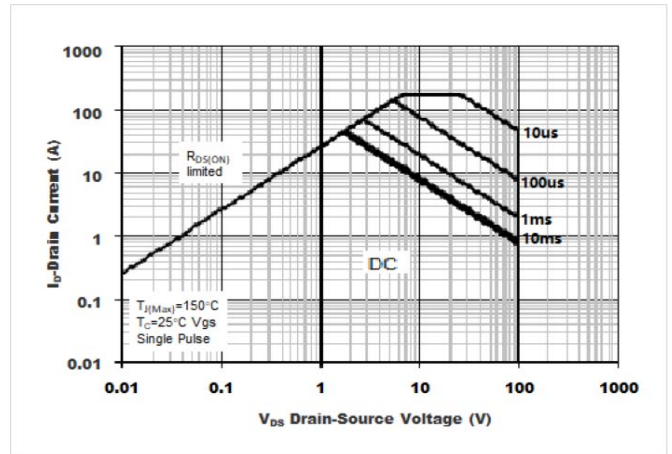


Figure8.Safe Operation Area

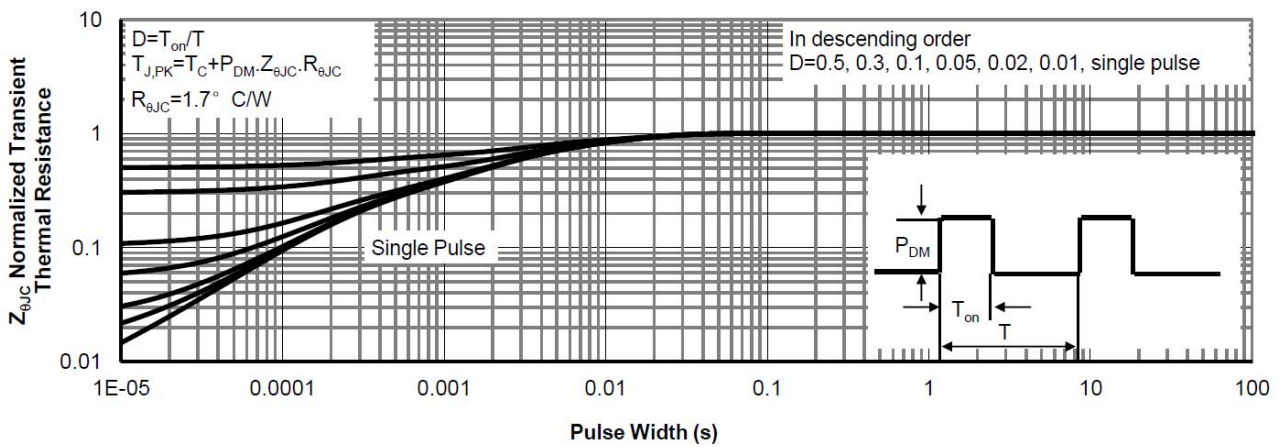
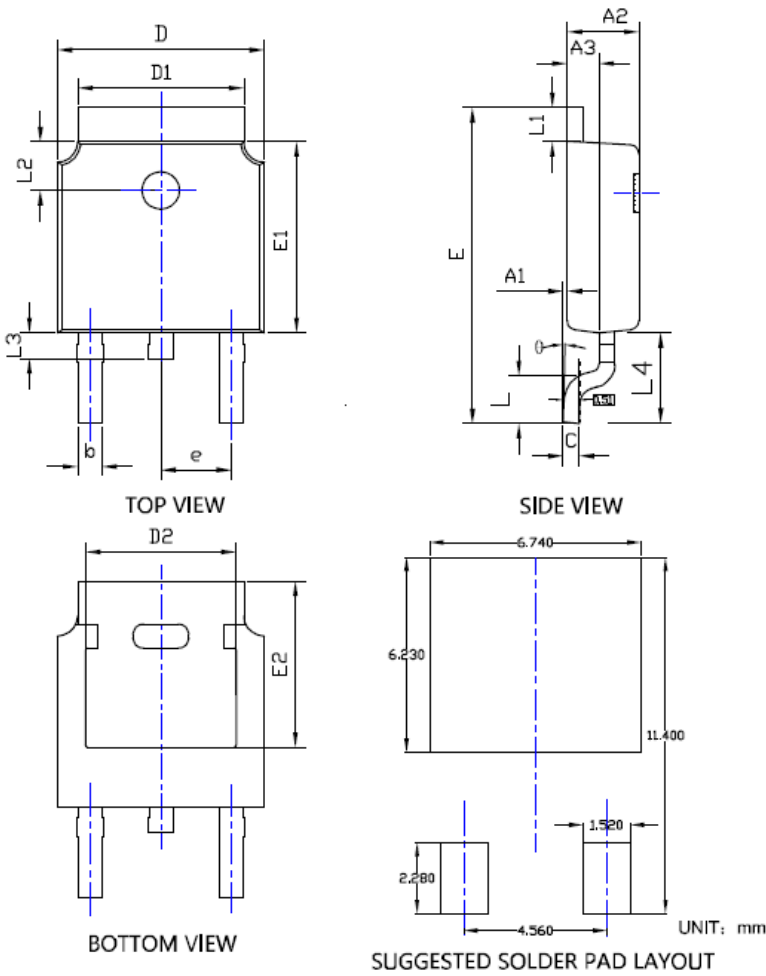


Figure9.Normalized Maximum Transient thermal impedance

■ TO-252 Package information



| SYMBOL | DIMENSIONS |       |       |            |        |        |
|--------|------------|-------|-------|------------|--------|--------|
|        | INCHES     |       |       | Millimeter |        |        |
|        | MIN.       | NOM.  | MAX.  | MIN.       | NOM.   | MAX.   |
| A1     | 0.000      | ---   | 0.008 | 0.000      | ---    | 0.200  |
| A2     | 0.087      | 0.091 | 0.094 | 2.200      | 2.300  | 2.400  |
| A3     | 0.035      | 0.039 | 0.043 | 0.900      | 1.000  | 1.100  |
| b      | 0.026      | 0.030 | 0.034 | 0.660      | 0.760  | 0.860  |
| c      | 0.018      | 0.020 | 0.023 | 0.460      | 0.520  | 0.580  |
| D      | 0.256      | 0.260 | 0.264 | 6.500      | 6.600  | 6.700  |
| D1     | 0.203      | 0.209 | 0.215 | 5.150      | 5.300  | 5.450  |
| D2     | 0.181      | 0.189 | 0.195 | 4.600      | 4.800  | 4.950  |
| E      | 0.390      | 0.398 | 0.406 | 9.900      | 10.100 | 10.300 |
| E1     | 0.236      | 0.240 | 0.244 | 6.000      | 6.100  | 6.200  |
| E2     | 0.203      | 0.209 | 0.215 | 5.150      | 5.300  | 5.450  |
| e      | 0.090BSC   |       |       | 2.286BSC   |        |        |
| L      | 0.049      | 0.059 | 0.069 | 1.250      | 1.500  | 1.750  |
| L1     | 0.035      | ---   | 0.050 | 0.900      | ---    | 1.270  |
| L2     | 0.055      | ---   | 0.075 | 1.400      | ---    | 1.900  |
| L3     | 0.240      | 0.310 | 0.039 | 0.600      | 0.800  | 1.000  |
| L4     | 0.114REF   |       |       | 2.900REF   |        |        |
| θ      | 0°         | ---   | 10°   | 0°         | ---    | 10°    |